Xper-PC



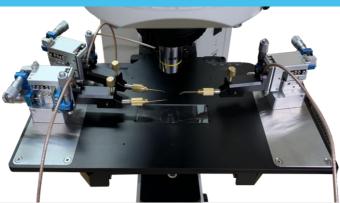
NANO**BASE**'s answer to photocurrent analysis

- ⁻ Photocurrent imaging and analysis
- ⁻ Ultra fast 2D scanning
- ⁻ Bright field microscopic imaging
- ⁻ Multiple laser selections
- ⁻ Measurement capabilities for source/drain, gate dependence



Scanning photocurrent microscopy

(SPCM) is a powerful mapping equipment used to investigate spatially resolved optoelectronic properties of semiconductors. Laser excitation by raster scanning generates a position-dependent photocurrent map from which carrier diffusion length, electric field distribution, doping concentration and more can be explored.





Xper-PC's 3-probe measurement using a high performance 2-channel sourcemeter unit provides a variety of photocurrent information, helping you obtain such information more easily by displaying detailed photocurrent differences in a large area in a form of high quality 2D maps.

The size of probe station is fully customizable, and we are more than happy to assist you with your even most unique needs so you can fulfill your research goals.

Not only semiconductor analysis, Xper-PC offers a wide range of applications as well serving both research and industrial fields.



Nano technology

Quality analysis for 1D, 2D nanomaterials



Semiconductor

Analysis of electrical characteristics



Optoelectronic materials

Analysis of electrical properties of materials



Solar cell

Analysis of electrical properties of solar cell film

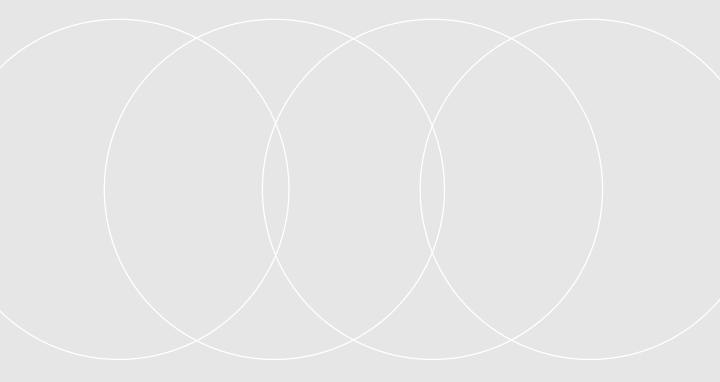


Battery material

Analysis of electrical properties of battery materials

Xper-PC specifications

Microscope	 Reflected LED illuminator for bright field Mechanical X-Y-Z stage with right-hand control (Automatically controlled Z-axis position option available upon request) Includes main frame, stage plate, control box, interface cable, power cable
Objective	- 10X, long WD 40X
Laser scanning module	 Wavelength range: 400 - 1000nm Laser scanning mode: Raster scan Scanning area: 200 um x 200 when using 40X 15 MP camera for optical image acquisition (FOV: 220 X 150 um when using 40X) Laser controller (USB 1.1)
Laser	 Up to three laser options may be added 405, 532, 633, 785 nm Freespace Fiber couple laser options also available
System platform	 1 slot to connect a laser density (ND) filter or a polarizer 2 slots to connect polarizers or waveplates
Photocurrent module	Probe positioner unit - Manipulator: LM lead guide with a fine knob - Magnetic base - Resolution: 3 um - Travel length: 6 mm On-stage plate - Vacuum chuck - Slide glass groove Probe tip - Material: Gold BeCu - Size: 0.5 x 25 mm - Either bending type or straight type selectable
Sourcemeter unit	 Voltage range: 100 mV ~ 40 V Programming resolution: 5 μV ~ 500 μV Source accuracy (1 year): 0.02% + 250 μV ~ 0.02% + 12 mV Current range: 100 nA ~ 10 A Programming resolution: 2 pA ~ 200 μA Source accuracy (1 year): 0.06% + 100 pA ~ 0.06% + 4 mA
NanoSpectrum software suite	 Photocurrent acquisition & imaging 2D current mapping data export format: .csv



NANOBASE

HQ #1406-1, 196 Gasan-digital-1-ro, Geumcheon-gu, Seoul 08502 South Korea

Hotline +82 70 8666 0233 **Fax** +82 2 852 9013

E-mail nbsales@nanobase.co.kr **Web** www.nanobase.co.kr